

IPW

Docket No.: 050195-0414

PATENT

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Application of

Customer Number: 20277

Saichirou KANEKO, et al.

Confirmation Number: 4944

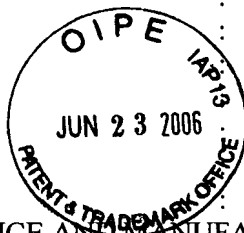
Application No.: 10/772,283

Group Art Unit: 2826

Filed: February 06, 2004

Examiner: Abraham, Fetsum

For: SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF



**INFORMATION DISCLOSURE STATEMENT**

Mail Stop ids  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

This Information Disclosure Statement is being filed under Rule 37 CFR 1.97(i), wherein applicants are submitting references to be placed in the file.

Accordingly, copies of the references as listed on the attached Form PTO-1449 are submitted herewith for placement in the file. No certification or fees are deemed necessary.

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,  
McDERMOTT WILL & EMERY LLP

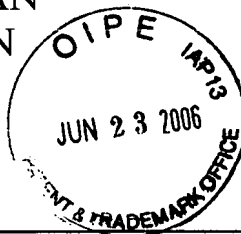
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**Please recognize our Customer No. 20277 as  
our correspondence address.**

# INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(PTO-1449)


 ATTY. DOCKET NO.  
**050195-0414**

 SERIAL NO.  
**10/772,283**

 APPLICANT  
**Saichirou KANEKO, et al.**

 FILING DATE  
**February 06, 2004**

 GROUP  
**2826**

## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Codez (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US			
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## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes -Number 4 -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
		JP 2002-359378	12/13/2002	Toshiba Corp.	English abstract	Yes	No
		JP 7-501181	02/02/1995	-----	English abstract		
		JP 08-288500	11/01/1996	Hitachi Ltd	English abstract		
		JP 11-307545	11/05/1999	Denso Corp	English abstract		
		JP 2002-543585	12/17/2002	-----	English abstract		
		JP 2000-101066	04/07/2000	Toshiba Corp	English abstract		

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	
		Official Action issued on October 11, 2005	

EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.